Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/607,057	Reexamination DE GRAAFF ET	AL.
Examiner	Art Unit	
JACKY X. ZHENG	2625	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. I ATENT DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0015447 A1	02-2002	Zhou, Minhua	375/240.25
*	В	US-2002/0140987 A1	10-2002	Ishikawa, Atsushi	358/402
*	С	US-2003/0231801 A1	12-2003	Baggs et al.	382/254
*	D	US-6,795,209 B1	09-2004	Patton et al.	358/1.18
*	Е	US-7,302,118	11-2007	Liu et al.	382/306
	F	US-			
	G	US-			
	Н	US-		-	
	T	US-		-	
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 589724 A2	03-1994	European Patent	SEARBY et al.	G06F 15/68
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
T	٧		
	w		
	×		

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.